

# WEST Search History

DATE: Monday, September 22, 2003

<u>Set Name</u>	<u>Query</u>	<u>Hit Count</u>	<u>Set Name</u>
side by side			result set
	<i>DB=USPT,PGPB,JPAB,EPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>		
L2	L1 and (chip or IC or (integrated adj circuit)) same (condition\$3 or pre-condition\$3 or precondition\$3)	605	L2
L1	((automat\$3 adj test\$3 adj equipment) or ATE) and (condition\$3 or precondition\$3 or pre-condition\$3)	10861	L1

END OF SEARCH HISTORY